Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,040	MAYO ET AL.	
Examiner	Art Unit	
John M. Frink	2112	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
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DATE	EXMR
11/9/2006	JMF
9/12/2006	JMF
11/9/2006	JMF
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